



## Features

- High Blocking Voltage with Low On-Resistance
- High Speed Switching with Low capacitances
- Avalanche Ruggednes

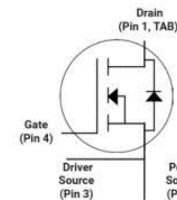
## Applications

- Solar Inverters
- Switch Mode Power Supplies
- Auxiliary power supplies
- Smart meters



TO-263-7L  
Package

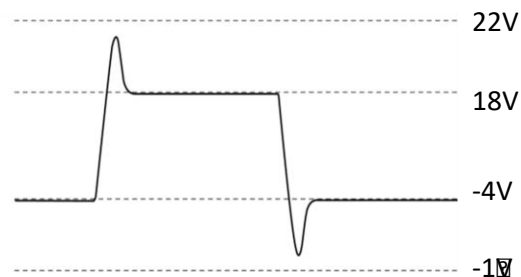
Ordering Part Number	Package	Marking
CMS120N080B	TO-263-7L	C1200NU



## Maximum Ratings (T<sub>c</sub> = 25 °C unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-source voltage	V <sub>DS</sub>	1200	V
Continuous drain current T <sub>c</sub> = 25°C T <sub>c</sub> = 100°C	I <sub>D</sub>	30 21	A
Source current(Body Diode) T <sub>c</sub> = 25°C T <sub>c</sub> = 100°C	I <sub>S</sub>	30 21	A
Pulsed drain current (T <sub>c</sub> = 25°C, t <sub>p</sub> limited by T <sub>jmax</sub> )	I <sub>D</sub> pulse	80	A
Avalanche energy, single pulse (L=10mH)	E <sub>AS</sub>	600	mJ
Gate-Source voltage	V <sub>GS</sub>	-4/+18	V
Gate-Source voltage (dynamic,Absolute maximum values)	V <sub>GSmax</sub>	-8/+22	V
Power dissipation (T <sub>c</sub> = 25°C)	P <sub>tot</sub>	136	W
Operating junction and storage temperature	T <sub>J</sub> , T <sub>stg</sub>	-55...+175	°C

- Example of acceptable V<sub>GS</sub> waveform





## Thermal Resistance

Parameter	Symbol	Value	Unit
Thermal resistance, junction – case. Max	$R_{thJC}$	1.1	°C/W
Thermal resistance, junction – ambient. Max	$R_{thJA}$	40	

## Electrical Characteristic (at $T_j = 25^\circ\text{C}$ , unless otherwise specified)

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Static Characteristics						
Drain-source breakdown voltage	V <sub>DSS</sub>	1200	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =100uA
Gate threshold voltage	V <sub>GS(th)</sub>	2.3	2.8	3.6	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =5mA
Zero gate voltage drain current	I <sub>DSS</sub>	-	1	10	μA	V <sub>DS</sub> =1200V, V <sub>GS</sub> =0V
		-	5	-		T <sub>C</sub> =25°C
		-	-	-		T <sub>C</sub> =175°C
Gate-source leakage current	I <sub>GSS</sub>	-		100	nA	V <sub>GS</sub> =18V, V <sub>DS</sub> =0V
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	75	85	mΩ	V <sub>GS</sub> =18V, I <sub>D</sub> =20A,
		-	125	-		T <sub>J</sub> =25°C
		-	-	-		T <sub>J</sub> =175°C
Transconductance	g <sub>fs</sub>	-	10	-	S	V <sub>DS</sub> =20V, I <sub>D</sub> =20A
Dynamic Characteristics						
Input Capacitance	C <sub>iss</sub>	-	920	-	pF	V <sub>DS</sub> = 1000V V <sub>GS</sub> = 0V T <sub>J</sub> = 25°C V <sub>AC</sub> = 25mV f = 1MHz
Output Capacitance	C <sub>oss</sub>	-	57	-		
Reverse Transfer Capacitance	C <sub>rss</sub>	-	3.9	-		
Gate Total Charge	Q <sub>G</sub>	-	40	-	nC	V <sub>DS</sub> = 800V V <sub>GS</sub> = -4/18V I <sub>D</sub> = 20A
Gate-Source charge	Q <sub>gs</sub>	-	7	-		
Gate-Drain charge	Q <sub>gd</sub>	-	19	-		
Turn-On Switching Energy	E <sub>ON</sub>	-	320	-	μJ	V <sub>DD</sub> = 800V V <sub>GS</sub> = -4/+15V I <sub>D</sub> = 20A R <sub>G</sub> = 0Ω L = 120uH
Turn-Off Switching Energy	E <sub>OFF</sub>	-	49	-		
Turn-on delay time	t <sub>d(on)</sub>	-	19	-	ns	
Rise time	t <sub>r</sub>	-	21	-		
Turn-off delay time	t <sub>d(off)</sub>	-	15	-		
Fall time	t <sub>f</sub>	-	17	-		
Gate resistance	R <sub>G</sub>	-	1.5	-	Ω	



### Body Diode Characteristics

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Body Diode Forward Voltage	$V_{SD}$	-	4.2	-	V	$V_{GS}=-4V, I_{SD}=10A,$ $T_J=25^{\circ}C$
		-	3.8	-		$V_{GS}=-4V, I_{SD}=10A,$ $T_J=175^{\circ}C$
Body Diode Forward Current	$I_{SD}$	-	-	30	A	$V_{GS}=-4V, T_J=25^{\circ}C$
Pulsed Body Diode Forward Current	$I_{SDM}$	-	-	89		
Reverse Recovery Time	$t_{rr}$	-	39.6	-	ns	$V_R = 800V,$ $V_{GS} = -4V$ $I_D = 20A$ $di/dt = 700A/\mu S$ $T_J = 25^{\circ}C$
Reverse Recovery Charge	$Q_{rr}$	-	141.1	-	nC	
Reverse Recovery Energy	$E_{REC}$	-	62.9	-	uJ	
Peak Reverse Recovery Current	$I_{rrm}$	-	6.2	-	A	
Charge Time	$t_A$	-	9.9	-	ns	
DisCharge Time	$t_B$	-	29.7	-	ns	
Reverse Recovery Time	$t_{rr}$	-	45.4	-	ns	$V_R = 800V,$ $V_{GS} = -4V$ $I_D = 20A$ $di/dt = 700A/\mu S$ $T_J = 175^{\circ}C$
Reverse Recovery Charge	$Q_{rr}$	-	397	-	nC	
Reverse Recovery Energy	$E_{REC}$	-	180.1	-	uJ	
Peak Reverse Recovery Current	$I_{rrm}$	-	13.8	-	A	
Charge Time	$t_A$	-	30.8	-	ns	
DisCharge Time	$t_B$	-	14.9	-	ns	



## Typical Performance Characteristics

Fig 1. Output Characteristic ( $T_J = -40^\circ\text{C}$ )

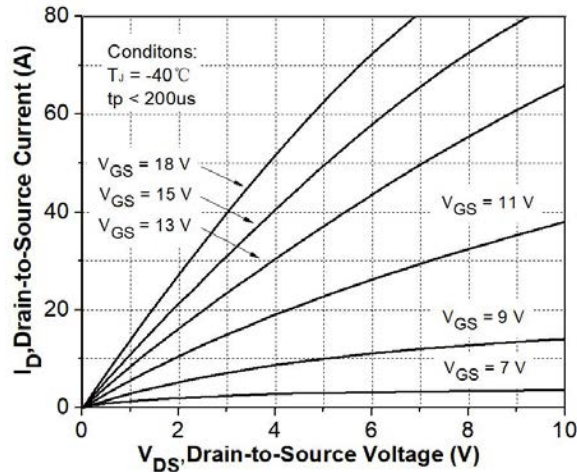


Fig 2. Output Characteristic ( $T_J = 25^\circ\text{C}$ )

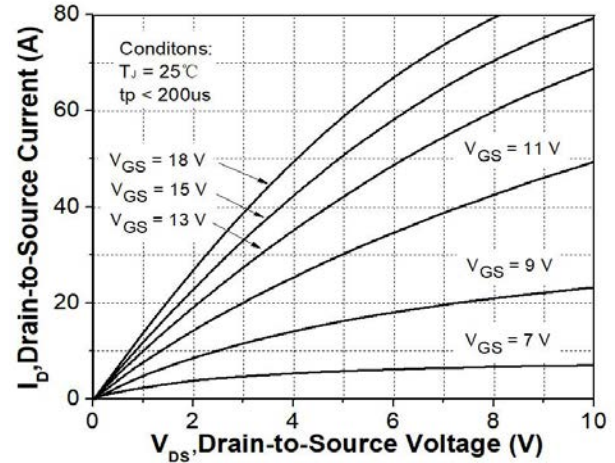


Fig 3. Output Characteristic ( $T_J = 175^\circ\text{C}$ )

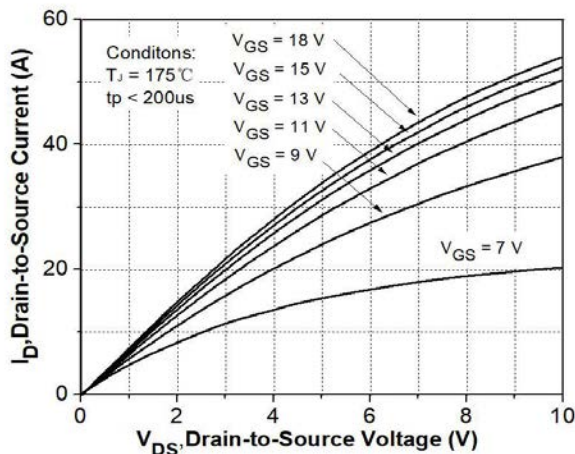


Fig 4:  $R_{DS(on)}$  Vs  $I_{DS}$  Characteristic

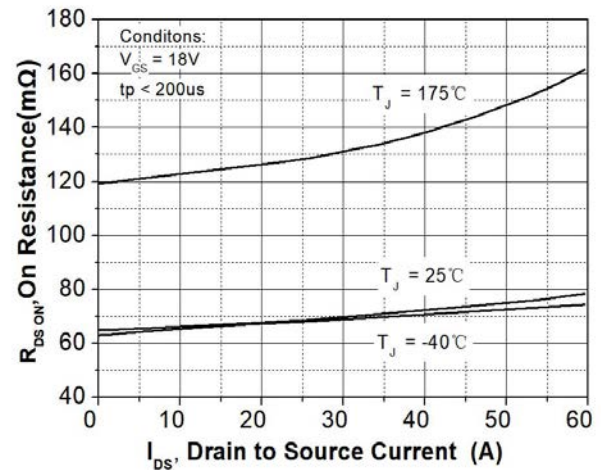


Fig 5:  $R_{DS(on)}$  vs. Temperature

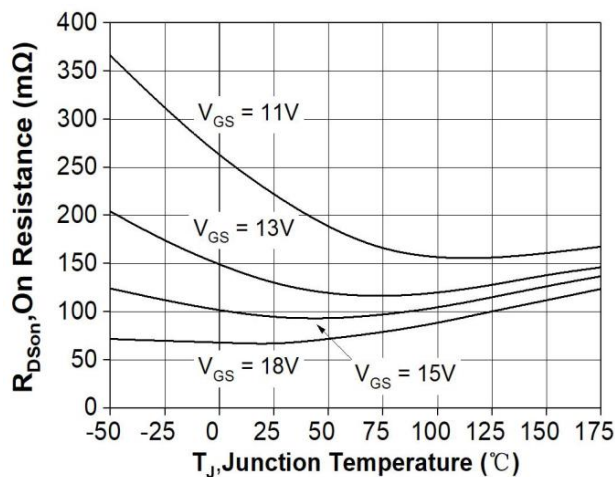


Fig 6: Transfer Characteristic

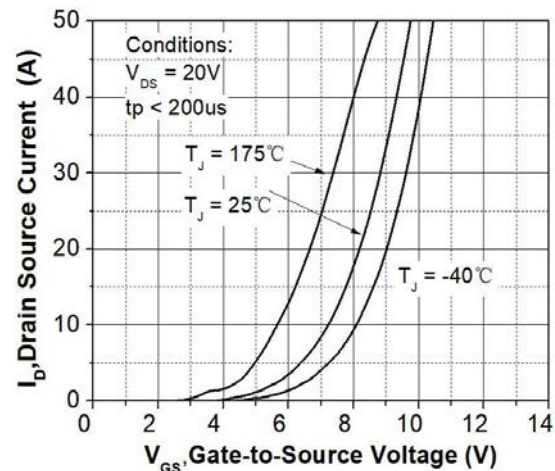




Fig 7: Body-diode Characteristic ( $T_J = -40^\circ\text{C}$ )

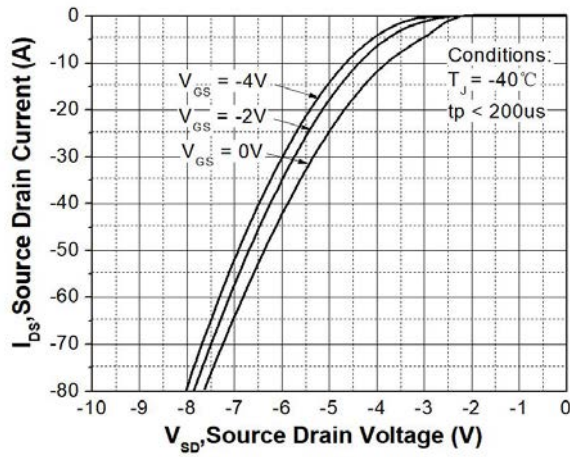


Fig 8: Body-diode Characteristic ( $T_J = 25^\circ\text{C}$ )

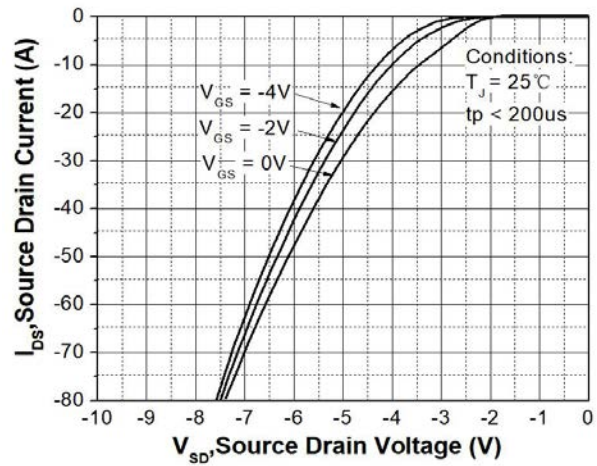


Fig 9: Body-diode Characteristic ( $T_J = 175^\circ\text{C}$ )

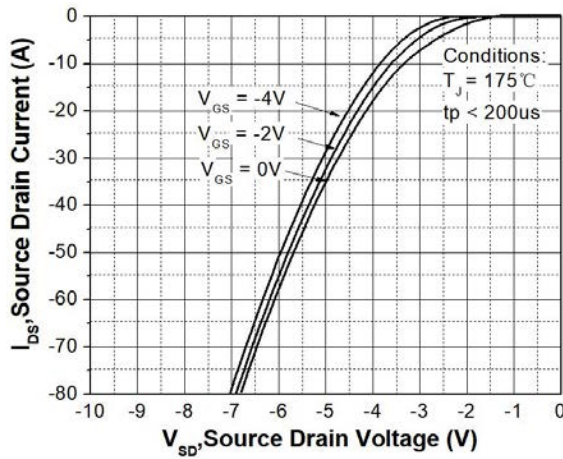


Fig 10:  $V_{TH}$  Vs  $T_J$  Temperature Characteristic

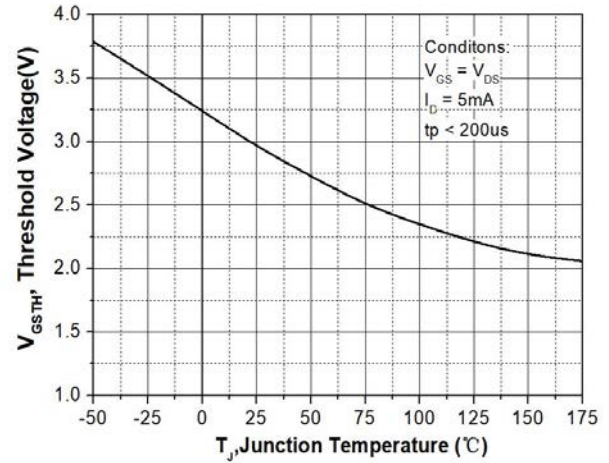


Fig 11: Gate Charge Characteristics

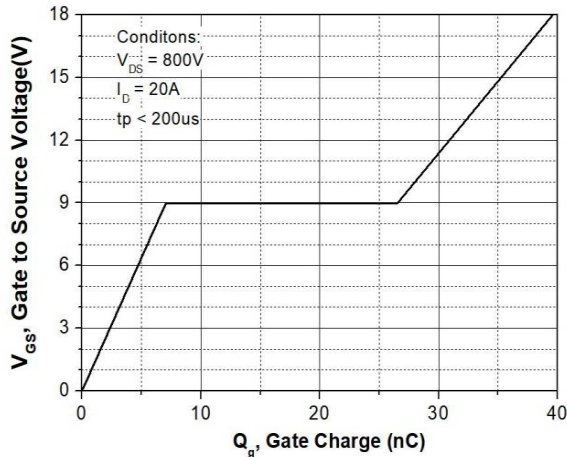


Fig 12: 3rd Quadrant Characteristic ( $T_J = -40^\circ\text{C}$ )

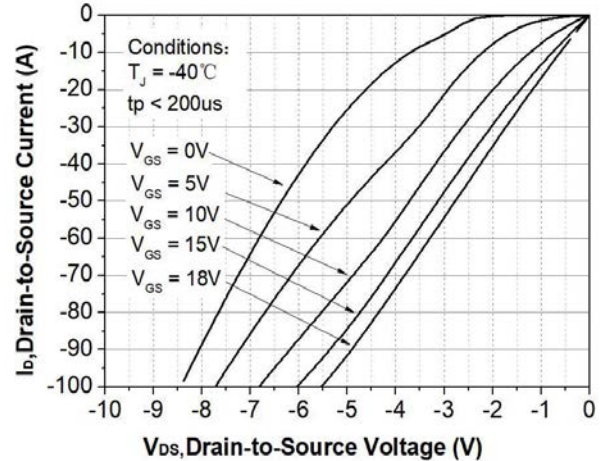




Fig 13: 3rd Quadrant Characteristic( $T_J=25^\circ\text{C}$ )

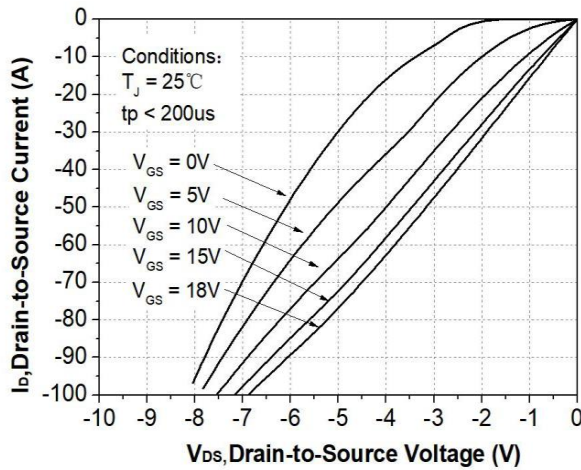


Fig 14: 3rd Quadrant Characteristic( $T_J=175^\circ\text{C}$ )

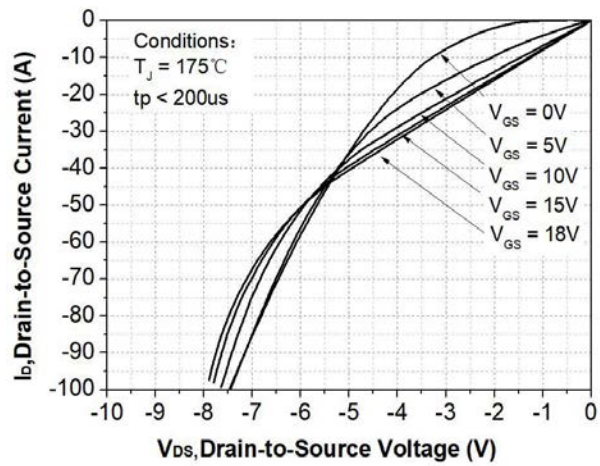


Fig 15: Capacitance Characteristic

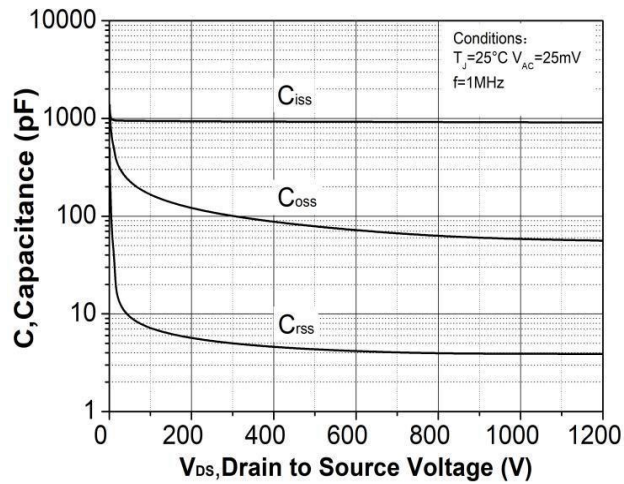


Fig 16: Safe Operating Area

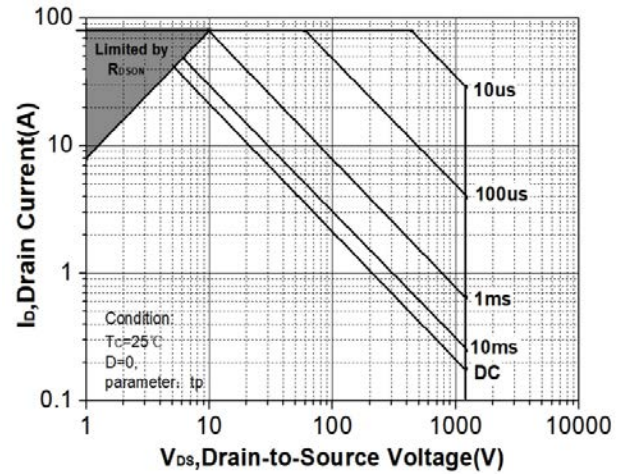
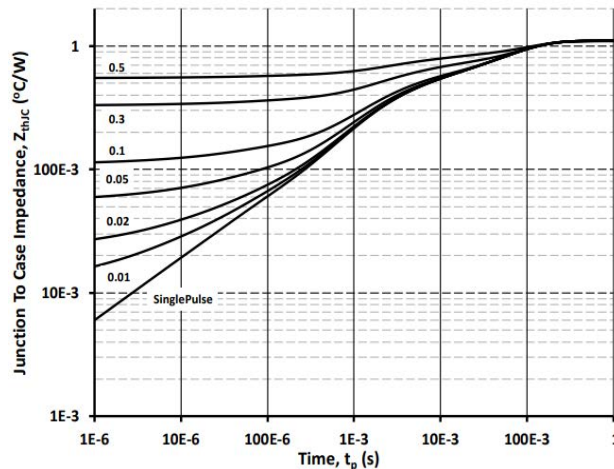
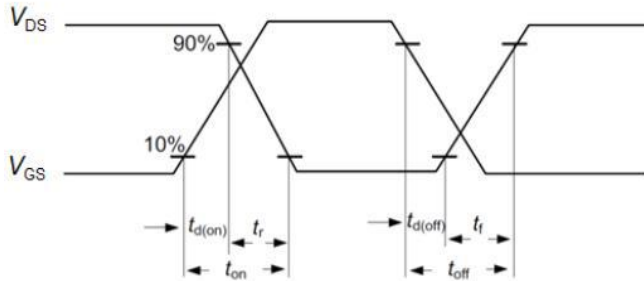


Fig 17: Transient Thermal Impedance

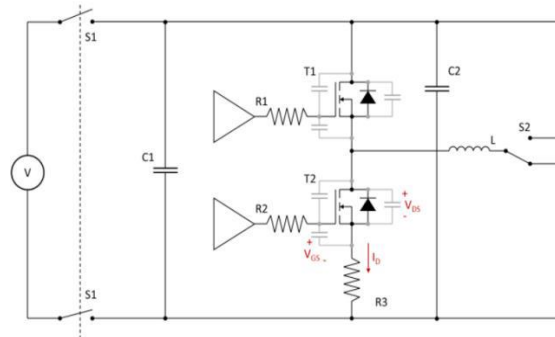


## Test Circuit Schematic

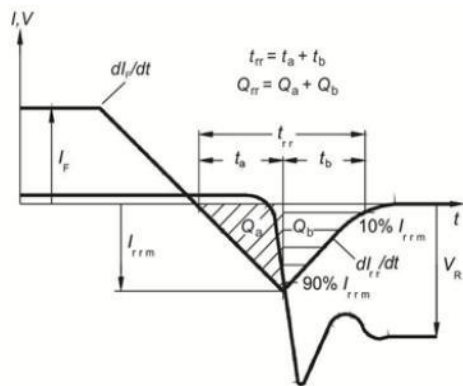
### Figure A. Definition of switching times



### Figure B. Dynamic test circuit



### Figure C. Definition of body diodeswitching characteristics

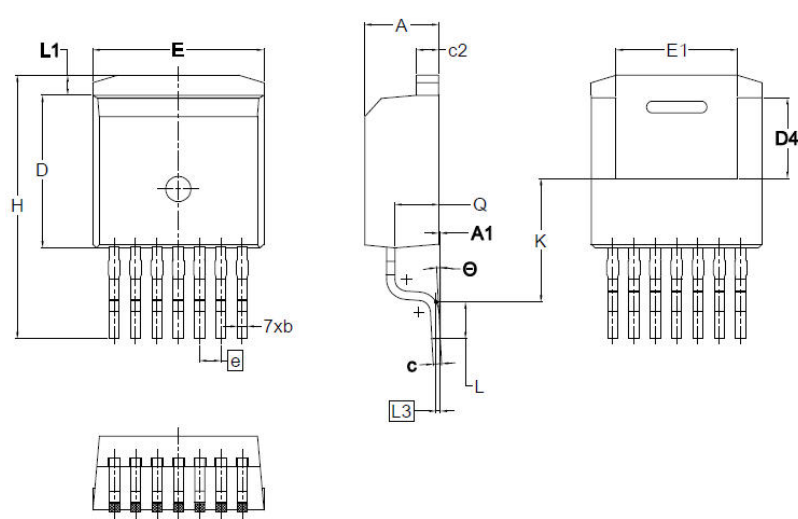


**Figure C. Definition of diode switching characteristics**



Package Dimensions

Package TO-263-7L



SYMBOL	DIMENSIONS		
	MIN.	NOM.	MAX.
A	4.30	4.40	4.50
A1	0.00	0.10	0.25
b	0.50	0.60	0.70
c	0.45	0.50	0.60
c2	1.20	1.30	1.40
D	8.93	9.08	9.23
D4	4.65	4.80	4.95
E	10.08	10.18	10.28
E1	6.82	7.22	7.62
e	1.27 BSC		
H	15.00	15.70	16.00
K	7.30		
L	1.90	2.20	2.50
L1	1.00	1.20	1.40
L3	0.25 BSC		
Q	2.45	2.60	2.75
$\Theta$	0°	3°	7°



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